

**Search Notes**

Application/Control No.

10/759,234

Examiner

Jonathan Liou

Applicant(s)/Patent under  
Reexamination

JIN ET AL.

Art Unit

2672

**SEARCHED**

Class	Subclass	Date	Examiner
701	200-226	6/6/2005	JL
345	all	6/6/2005	JL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See the attachment for the East Search History	6/6/2005	JL
IEEE search for aerial, building, and detect	6/6/2005	JL
Google search for aerial, building, photogrammy	6/6/2005	JL